

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/509,979 | | Applicant(s)/Patent Under Reexamination QUINET ET AL. | |
| | Examiner Abdou Karim Seye | | Art Unit 2194 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-5,987,466 | 11-1999 | Greer et al. | 707/10 |
| * | B | US-6,343,085 | 01-2002 | Krishnan et al. | 370/468 |
| * | C | US-6,563,517 | 05-2003 | Bhagwat et al. | 715/735 |
| * | D | US-5,778,372 | 07-1998 | Cordell et al. | 707/100 |
| * | E | US-6,154,769 | 11-2000 | Cherkasova et al. | 709/207 |
| * | F | US-6,421,733 | 07-2002 | Tso et al. | 709/246 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.